The VITA module enables nanoscale thermal analysis (nTA), a novel technique that allows the determination of the local transition temperature on the surface of a material with nanoscale spatial resolution. By providing quantitative characterization, nTA can help identify materials and their phase separation and component distribution (or aggregation) at the nanoscale. The technique utilizes a specialized thermal probe to heat a very small region on the sample surface and locally measure its thermal properties, including such thermal transitions as melting points and glass transitions. The thermal probe is similar in geometry and physical characteristics to standard silicon atomic force microscopy (AFM) probes, and thus enables the generation of high-resolution sample topography maps using contact mode and TappingMode™ techniques. The AFM image can be used to target locations of interest for thermal analyses, which can then be executed in a matter of seconds. In this way, nTA marries the resolution of AFM to the unambiguous and quantitative data of thermal analysis. This application note describes the technique and demonstrates its benefits in a number of applications.

Nanoscale Thermal Analysis

Thermal methods, such as differential scanning calorimetry (DSC), thermomechanical analysis (TMA), and dynamic mechanical analysis (DMA), are well-established techniques for characterizing the transition temperature of materials. However, a serious limitation of conventional thermal methods is that they give only a sample-averaged response and cannot provide information on localized defects, nor can they give the thermal properties of coatings/films less than a few microns in thickness. A DSC measurement, for example, may indicate the presence of more than one phase, but the technique cannot generally give any information regarding the size or distribution of phases. This particularly impacts scientists working with polymer blends (where the blend morphologies are crucial to determining their material properties), coatings (where imperfections such as gel formations can seriously impact performance), multilayer films, and composites.

AFM has been routinely used to characterize the topography of such materials, as well as the distribution of their components. In some types of samples, the material,
of the cantilever to heat up when current flows through the conductive path. The cantilever itself is made of silicon and the path is created by implanting the silicon with different dopant concentrations. Figure 1 shows an SEM image of the thermal probe used in nTA. The probe has a similar aspect ratio and end radius to standard etched silicon probes, allowing high-resolution imaging in either contact mode or TappingMode. Because the material is doped silicon, the cantilever can withstand much higher currents than metal film cantilevers, and therefore achieves much higher temperatures. Controllable heating can be performed up to temperatures as high as 350–400°C. The high thermal conductivity of silicon enables very high temperature ramp rates, reaching maximum temperature in less than 100 microseconds, thus allowing for rapid (high throughput and localized) sample heating. An additional benefit of the cantilevers is their ability to withstand pulse heating to around 1000°C, which can be used to clean off any contamination that adheres to the apex of the probe.

The temperature range accessible with the nTA probes, and the need for localized sample heating (thus limiting thermal conductivity of the sample) makes the nTA technique an ideal match for polymers. Thus, nTA applications have been focused on polymeric and pharmaceutical materials. Following are a number of applications in these areas showing the utility of nTA to more fully characterize a material at the nano- or microscale. In addition, the usage of the heated probes in scanning probe

Figure 1. An SEM image of the microfabricated thermal probe used for nTA measurements. The inset is a zoom of the tip, which makes contact with the sample surface.
microscopy is continuing to develop new and interesting techniques and applications, from nanoscale lithography to temperature-dependent electrical characterization of samples.

**Polymer Blends**

Polymer blends are used in a wide range of industries due to the fine tuning of material properties possible through proper component choice. AFM has been used to help characterize the domain size and distribution in a wide range of polymer blend samples. As shown in figures 2 and 3, the domains can be visualized using both topography data and phase imaging. This constitutes an ideal starting point for nTA, which can then be used to help identify which domain is which, as well as if the domains are fully phase segregated or are intermixed. Since the samples in these figures are immiscible blends, the primary question is which material is which.

All of the materials in these blends (polystyrene, low-density-polyethylene, polyethylene oxide, syndiotactic polypropylene) are relatively stiff in comparison with the cantilever at room temperature, so material identification based on mechanical property variation can prove unreliable. Transition temperatures, on the other hand, differ greatly between the components, allowing for straightforward component identification using nTA. Further information about domain thickness can be gleaned in the case of the polyethylene oxide – syndiotactic polypropylene (PEO-sPP) blend, where probe penetration into small PEO domains is seen to be quickly followed by penetration into an underlying sPP matrix.

The nTA data presented here (figures 2 and 3) were generated using heating rates of 5˚C per second. While significantly faster than heating rates typically employed for bulk thermal analysis, this high rate is typical for nTA and it enables localized heating and high throughput. The unambiguous determination of blend distribution shown in figure 2 was accomplished within just a few minutes. The instrumentation allows adjustment of the heating rate over a wide range to both slower and significantly faster heating rates, as required for the experiment.

**Multilayer Films**

Multilayer films represent a standard choice of material for most packaging applications. The different layers in a multilayer film contribute different attributes to the final film, including physical rigidity and barrier properties. While bulk thermal analysis can be used to measure the complete composite stack, nTA allows individual, in-situ thermal property measurements within individual layers. This enables the identification of each layer, as well as the identification of individual defects within any layer. Additionally, the transition temperature of the individual films can be mapped to detect the possible presence...
of transition temperature gradients or inhomogeneities. Thermal gradients through the thickness of the film can occur during processing of the film due to differences in thermal history between the two sides. Figure 4 shows an example of a simple multilayer film used for food packaging. The center ethylene vinyl alcohol (EVOH) film is used as a barrier film and has a lower transition temperature than the adjacent “tie” layer or the outside high-density polyethylene layers.

**Coatings**

Organic polymeric materials are widely used as coatings in a growing number of applications due to the opportunities they provide for fine tuning performance, in particular appearance and such surface properties as corrosion resistance. As the range of applications grows and the requirements become more demanding, coating complexity is increasing and thickness is decreasing. This trend towards thin, complex coatings hampers investigation with traditional thermal analysis equipment. An additional challenge arises from the recent focus on the curing rate, where environmental regulations and manufacturing cost considerations are driving a minimization of drying time. Thus, the analysis of coatings increasingly demands spatial and temporal resolution.

**Conclusions**

By enabling nanoscale thermal analysis, the VITA module combines the worlds of microscopy and thermal analysis, thus revealing the spatial distribution of thermal properties and inhomogeneities. This ability makes the VITA accessory uniquely valuable in applications ranging from analysis of polymer blends or composites to in-situ measurements of thin coatings. The technique is made possible by a microfabricated thermal probe that allows scientists to heat samples locally and measure thermal properties of regions on the nano- and microscale.

The nTA technique meets all the requirements imposed by modern coating applications. An individual measurement is performed within seconds, allowing for the quantification of curing times that are minutes in duration. The nanoscale spatial resolution afforded by nTA extends thermal analysis to thinner coatings, and by offsetting the probe a small distance laterally after each measurement to an undisturbed location, either spatial inhomogeneities or time dependences can be determined.

Figure 5 shows an example application using VITA nTA to identify the distribution of materials in a two-component solid lubricant coating. The two materials were spray deposited together on an aluminum substrate. Optically, it appeared that the coating was not continuous. However, neither optical nor AFM data could differentiate the two materials. By using nTA, the uncoated surface could clearly be identified because of the lack of probe penetration into the surface throughout the temperature range, as demonstrated with the green curve in the VITA data. The two other components could be identified by their easily distinguished transition temperatures of ~85°C versus ~125°C. By mapping a number of the islands, it was also shown that the two components formed separate islands and did not intermix.
Figure 4. (a) 25μm x 12μm TappingMode topography image of a cross-sectioned multilayer film used for food packaging. (b) VITA nTA data showing distinct thermal transitions in each layer. The blue curves were obtained in the outer packaging layers (at the left and right sides of the AFM image) and exhibit the high transition temperatures indicative of high-density polyethylene. The green curve was obtained in the center layer (center of the AFM image) and exhibits the much lower transition temperature characteristic of ethylene vinyl alcohol (EVOH), a typical choice for a barrier layer. The red curve with its intermediate transition temperature was obtained in the thin layer surrounding the center layer.

Figure 5. An optical image (right) of a two-component solid lubricant coating. The circles indicate locations where nTA data was taken, and the colors correlate with the curves in the graph (left). The nTA data in the graph clearly identifies the two different coatings by their distinct transition temperatures. The complete absence of transition temperatures in the green curve shows that neither component is present at the location of the green circle.

Author

Thomas Mueller, Ph.D.,
Bruker Nano Surfaces Division (thomas.mueller@bruker-nano.com)